TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOS IV)

# **TPCP8002**

#### Notebook PC Applications Portable Equipment Applications

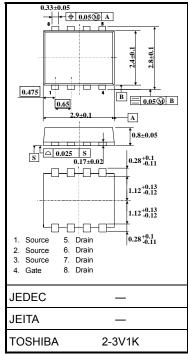
- Lead (Pb)-Free
- Small footprint due to small and thin package
- Low drain-source ON-resistance : RDS (ON) = 7 m $\Omega$  (typ.)
- High forward transfer admittance :|Yfs| = 36 S (typ.)
- Low leakage current
   : IDSS = 10 µA (VDS = 20 V)
- Enhancement mode
   : Vth = 0.5 to 1.2 V (VDS = 10 V, ID = 0.2 mA)

### Maximum Ratings (Ta = 25°C)

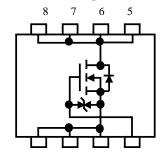
Ch	aracteristic		Symbol	Rating	Unit	
Drain-source v	voltage		V <sub>DSS</sub>	20	V	
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )		V <sub>DGR</sub>	20	V		
Gate-source v	oltage		V <sub>GSS</sub>	±12	V	
Drain current	DC (1	Note 1)	I <sub>D</sub>	9.1	A	
Dialiticulient	Pulse (f	Note 1)	I <sub>DP</sub>	36.4		
Drain power dissipation (t = 5 s) (Note 2a)			PD	1.68	w	
Drain power dissipation (t = 5 s) (Note 2b)		PD	0.84			
Single pulse a (Note 3)	valanche ener	ſġy	Eas	21.5	mJ	
Avalanche cur	rent		I <sub>AR</sub>	9.1	Α	
Repetitive avalanche energy (Note 4)		E <sub>AR</sub>	0.168	mJ		
Channel temperature			T <sub>ch</sub>	150	°C	
Storage tempe	erature range		T <sub>stg</sub>	-55~150	°C	

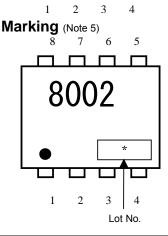
Note: For Notes 1 to 5, refer to the next page.

This transistor is an electrostatic-sensitive device. Handle with care.



#### **Circuit Configuration**





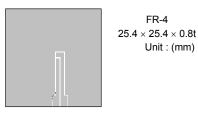
Unit: mm

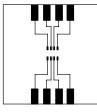
#### **Thermal Characteristics**

Characteristic	Symbol	Max	Unit
Thermal resistance, channel to ambient $(t = 5 s)$ (Note 2a)	R <sub>th (ch-a)</sub>	74.4	°C/W
Thermal resistance, channel to ambient $(t = 5 s)$ (Note 2b)	R <sub>th (ch-a)</sub>	148.8	°C/W

Note 1: The channel temperature should not exceed 150  $^{\circ}\mathrm{C}$  during use.

Note 2: (a) Device mounted on a glass-epoxy board (a) (b) Device mounted on a glass-epoxy board (b)





FR-4 25.4 × 25.4 × 0.8t Unit : (mm)

Note 3:  $V_{DD} = 16 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$  (initial), L = 0.2 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AR</sub> = 9.1 A

- Note 4: Repetitive rating: pulse width limited by maximum channel temperature.
- Note 5: on the lower left of the marking indicates Pin 1.

\* Weekly code (3 digits):



Week of manufacture - (01 for the first week of the year, continuing up to 52 or 53)

Year of manufacture

(the last digit of the calendar year)

## **Electrical Characteristics (Ta = 25°C)**

Cha	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I <sub>GSS</sub>	$V_{GS}$ = ±10 V, $V_{DS}$ = 0 V	_		±10	μA
Drain cut-off curre	ent	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	_		10	μA
Drain-source brea	ate threshold voltage rain-source ON-resistance orward transfer admittance put capacitance everse transfer capacitance utput capacitance Rise time Turn-on time	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	20		_	V
voltage		V (BR) DSX	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = −12 V	8	8         0.5      1.2        10     13.7        7     10       18     36         3700         400		v
Gate threshold voltage		V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.2 mA	0.5		1.2	V
Desire excess ON		D	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 4.5 A		10	13.7	mΩ
Drain-source ON-	resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 4.5 A	$\begin{array}{c c} r, I_D = 4.5 \text{ A} & & 7 \\ I_D = 4.5 \text{ A} & 18 & 36 \\ \hline & & 3700 \end{array}$		10	11152
Forward transfer admittance		Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 4.5 A	18	36	_	S
Input capacitance	Input capacitance				3700	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	400	_	
Output capacitance		C <sub>oss</sub>			450	_	
voltage Gate threshold volt Drain-source ON-re Forward transfer ad Input capacitance Reverse transfer ca Output capacitance Switching time	Rise time	tr	$V_{GS} \stackrel{5V}{_{0V}} \prod_{I_D} = 4.5 \text{ A}$ $V_{GS} \stackrel{5V}{_{0V}} \prod_{V \in I_D} \stackrel{I_D}{_{0V}} = 4.5 \text{ A}$ $V_{OUT} \stackrel{O}{_{0V}} V_{OUT}$ $\stackrel{O}{_{0V}} \stackrel{O}{_{0V}} V_{OUT}$ $\stackrel{O}{_{0V}} \stackrel{O}{_{0V}} \stackrel{V_{OUT}}{_{0V}}$ $\stackrel{O}{_{0V}} \stackrel{V_{OUT}}{_{0V}} \stackrel{V_{OUT}}{_{0V}}$ $\stackrel{V_{OD}}{_{0V}} \simeq 10 \text{ V}$ $Duty \le 1\%, t_w = 10 \mu\text{s}$	_	14	_	. ns
	Turn-on time	t <sub>on</sub>			24	_	
	Fall time	t <sub>f</sub>			30	_	
	Turn-off time	t <sub>off</sub>			110	_	
Total gate charge (gate-source plus gate-drain)		Qg	V <sub>DD</sub> ≈ 16 V, V <sub>GS</sub> = 5 V, I <sub>D</sub> = 9.1 A		48		
Gate-source charge 1		Q <sub>gs1</sub>		—	8	_	nC
Gate-drain ("Mille	r") charge	Q <sub>gd</sub>		_	12	_	

# Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteris	tic	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I <sub>DRP</sub>	—	_	_	36.4	А
Forward voltage (diode)		V <sub>DSF</sub>	I <sub>DR</sub> = 9.1 A, V <sub>GS</sub> = 0 V	_	—	-1.2	V

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